

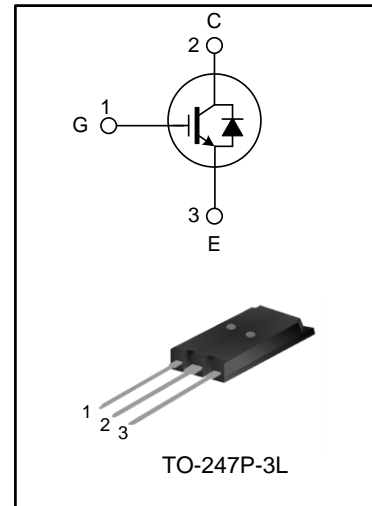
200A, 750V FIELD STOP IGBT

DESCRIPTION

The SGTQ200V75SDB1PW field stop IGBT adopts Silan Field Stop 5 technology. It features low conduction loss and switching loss, is applicable to Motor Drives, DC/AC converter.

FEATURES

- ◆ $V_{CE(sat)}=1.40V$ (典型值) @ $I_C=200A$
- ◆ $T_{jmax}=175^{\circ}C$
- ◆ Positive temperature coefficient
- ◆ Optimized parameter consistence
- ◆ High input impedance



NOMENCLATURE

SGTQ 200 V 75 S D B 1 PW	
IGBT series	Package
Automotive	PW: TO-247P-3L
Current, 70: 70A	1,2,3... : Version No.
N : N-channel	Blank: Standard diode
NE : N-channel planner gate with ESD	M : Standard diode, full range
T : Field Stop 3/4	R : Rapid diode
U : Field Stop 4+	B : Rapid diode, full range
V : Field Stop 5	S : Ultra soft diode, full range
W : Field Stop 6	D : packaged with fast recovery diode
X : Field Stop 7	R : RC IGBT
Voltage, 65: 650V 120: 1200V	L : Ultra low switching, recommended frequency ~2KHz
	Q : Low switching, recommended frequency 2~20KHz
	S : Standard frequency, recommended frequency 5~40KHz
	F : Fast switching, recommended frequency 10~60KHz
	UF : Ultra fast switching, recommended frequency 40KHz~

ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing Type
SGTQ200V75SDB1PW	TO-247P-3L	Q200V75SDB1	Halogen free	Tube

ABSOLUTE MAXIMUM RATINGS (UNLESS OTHERWISE NOTED, T_C=25°C)

Characteristics		Symbol	Ratings	Unit
Collector to Emitter Voltage		V _{CE}	750	V
Gate to Emitter Voltage		V _{GE}	±20	V
Transient Gate-Emitter Voltage (t _p ≤10μs, D<0.010)		V _{GE}	±30	V
Collector Current	T _C =25°C	I _C	400	A
	T _C =100°C		200	
Pulsed Collector Current		I _{CM}	600	A
Diode current	T _C =25°C	I _F	400	A
	T _C =100°C		200	
Diode Pulse Current		I _{FM}	600	A
Power Dissipation (T _C =25°C)		P _D	1000	W
Operating Junction Temperature		T _J	-55~+175	°C
Storage Temperature Range		T _{stg}	-55~+175	°C

THERMAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Thermal Resistance, Junction to Case (IGBT)	R _{θJC}	--	--	--	0.15	°C/W
Thermal Resistance, Junction to Case (FRD)	R _{θJC}	--	--	--	0.26	°C/W
Thermal Resistance, Junction to Ambient (IGBT)	R _{θJA}	--	--	--	40	°C/W
Soldering Temperature (in line)	T _{sold}	15 ⁺² ₀ sec, 1time	--	--	260	°C

ELECTRICAL CHARACTERISTICS OF IGBT (UNLESS OTHERWISE NOTED, $T_C=25^{\circ}\text{C}$)

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Collector to Emitter Breakdown Voltage	BV_{CE}	$V_{GE}=0V, I_C=1mA$	750	--	--	V
C-E Leakage Current	I_{CES}	$V_{CE}=750V, V_{GE}=0V$	--	--	50	μA
G-E Leakage Current	I_{GES}	$V_{GE}=20V, V_{CE}=0V$	--	--	± 100	nA
G-E Threshold Voltage	$V_{GE(th)}$	$I_C=250\mu A, V_{CE}=V_{GE}$	4.0	5.4	6.8	V
Collector to Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=200A, V_{GE}=15V, T_C=25^{\circ}\text{C}$	--	1.40	1.60	V
		$I_C=200A, V_{GE}=15V, T_C=150^{\circ}\text{C}$	--	1.55	--	V
		$I_C=200A, V_{GE}=15V, T_C=175^{\circ}\text{C}$	--	1.58	--	V
Input Capacitance	C_{ies}	$V_{CE}=30V$ $V_{GE}=0V$ $f=1MHz$	--	21370	--	pF
Output Capacitance	C_{oes}		--	498	--	
Reverse Transfer Capacitance	C_{res}		--	94	--	
Turn-On Delay Time	$T_{d(on)}$	$V_{CE}=400V$ $I_C=200A$ $R_g=10\Omega$ $V_{GE}=15V$ inductive load $T_C=25^{\circ}\text{C}$	--	135	--	ns
Rise Time	T_r		--	112	--	
Turn-Off Delay Time	$T_{d(off)}$		--	534	--	
Fall Time	T_f		--	65	--	
Turn-On Switching Loss	E_{on}		--	13.0	--	mJ
Turn-Off Switching Loss	E_{off}		--	7.5	--	
Total Switching Loss	E_{st}		--	20.5	--	
Total Gate Charge	Q_g	$V_{CE}=400V, I_C=100A, V_{GE}=15V$	--	750	--	nC
Gate to Emitter Charge	Q_{ge}		--	178	--	
Gate to Collector Charge	Q_{gc}		--	257	--	

ELECTRICAL CHARACTERISTICS OF FRD ($T_C=25^{\circ}\text{C}$, UNLESS OTHERWISE NOTED)

Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Diode Forward Voltage	V_{FM}	$I_F=200A, T_C=25^{\circ}\text{C}$	--	1.80	2.20	V
		$I_F=200A, T_C=150^{\circ}\text{C}$	--	1.81	--	
		$I_F=200A, T_C=175^{\circ}\text{C}$	--	1.82	--	
Diode Reverse Recovery Time	T_{rr}	$I_{ES}=200A, di_{ES}/dt=200A/\mu s,$ $T_C=25^{\circ}\text{C}$	--	212	--	ns
Diode Reverse Recovery Charge	Q_{rr}		--	8.1	--	μC
Diode Reverse Recovery Current	I_{rrm}		--	11	--	A

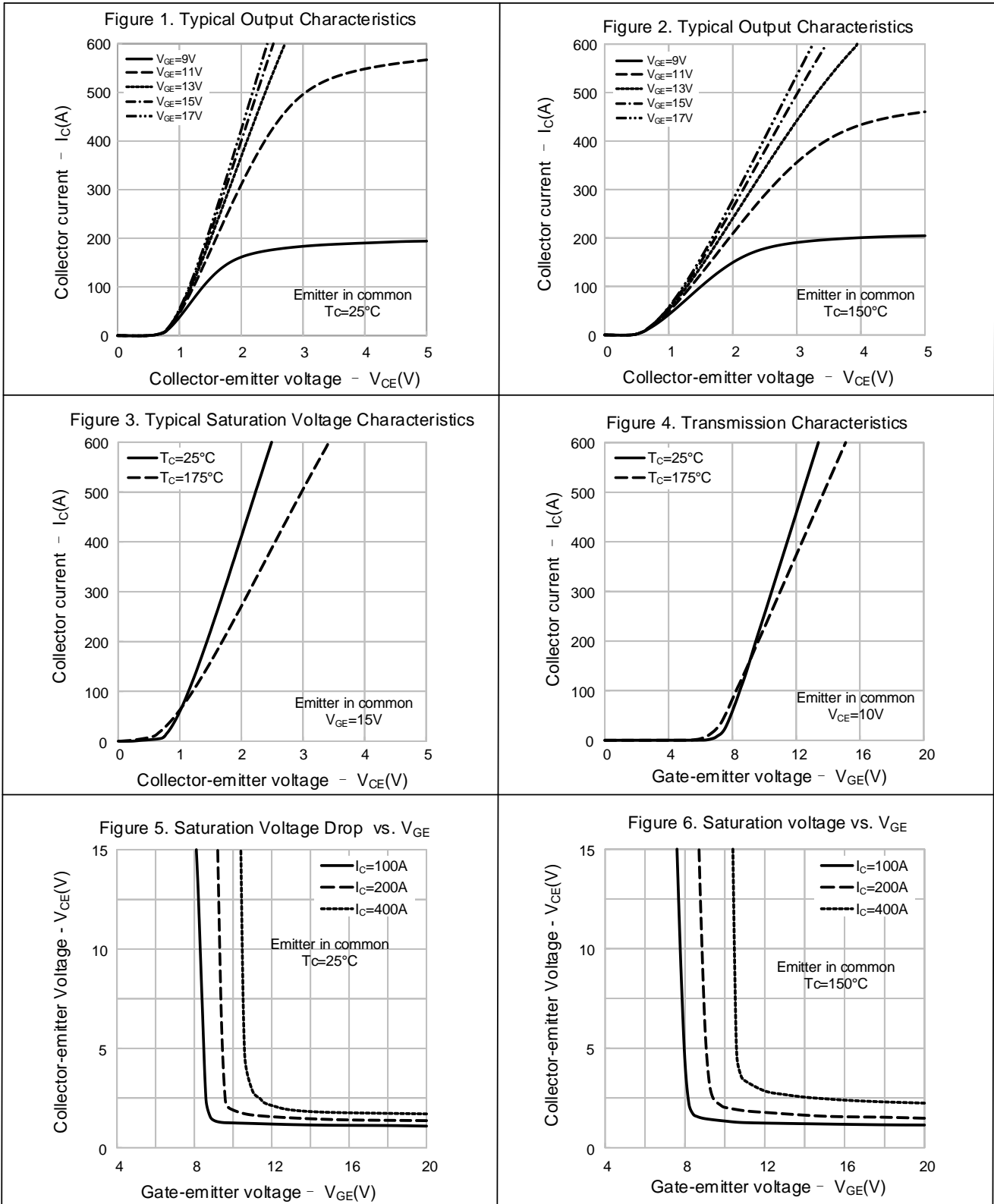
ELECTRICAL CHARACTERISTICS OF IGBT (T_C=175°C)

Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Turn-On Delay Time	T _{d(on)}	V _{CE} =400V I _C =200A R _g =10Ω V _{GE} =15V	--	130	--	ns
Rise Time	T _r		--	121	--	
Turn-Off Delay Time	T _{d(off)}		--	605	--	
Fall Time	T _f		--	96	--	
Turn-On Switching Loss	E _{on}	inductive load T _C =175°C	--	17.5	--	mJ
Turn-Off Switching Loss	E _{off}		--	10.2	--	
Total Switching Loss	E _{st}		--	27.7	--	

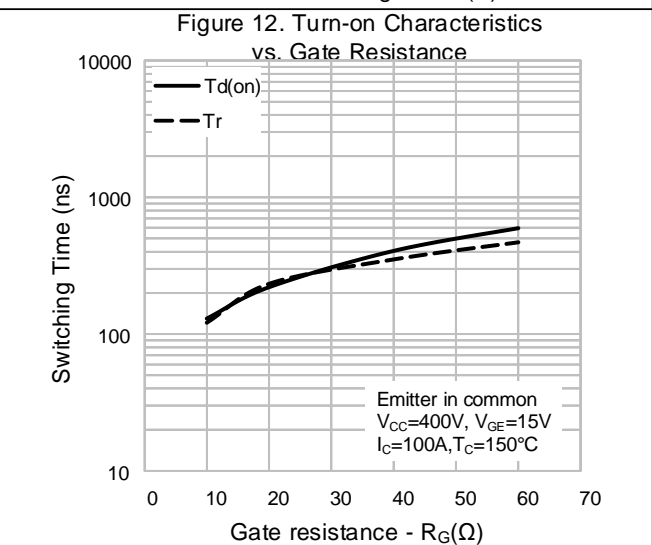
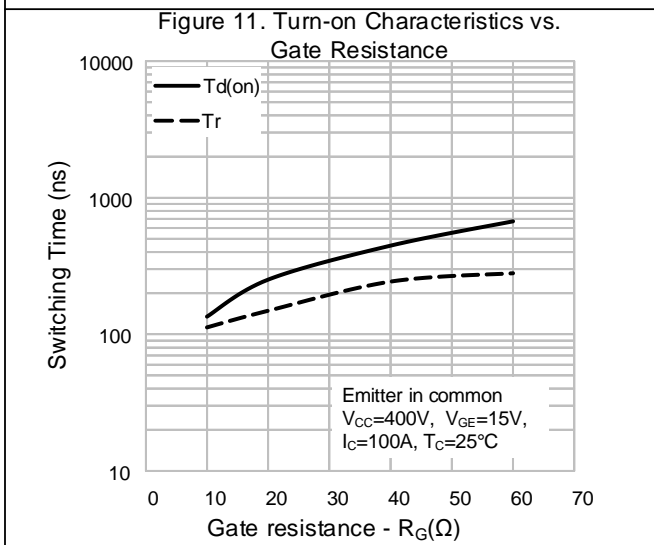
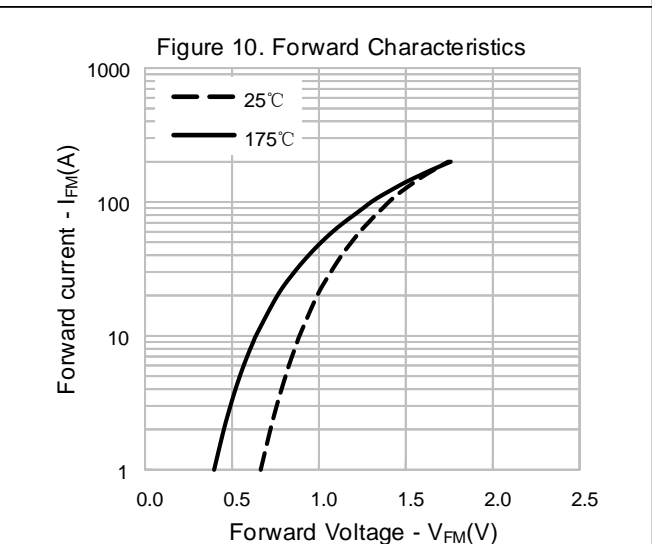
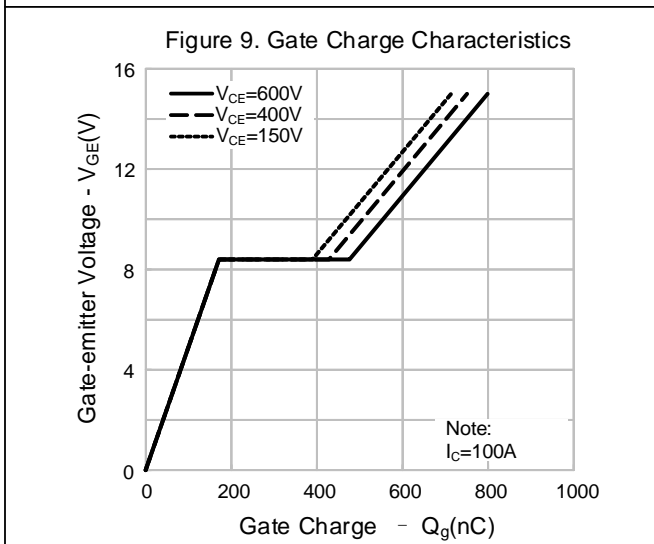
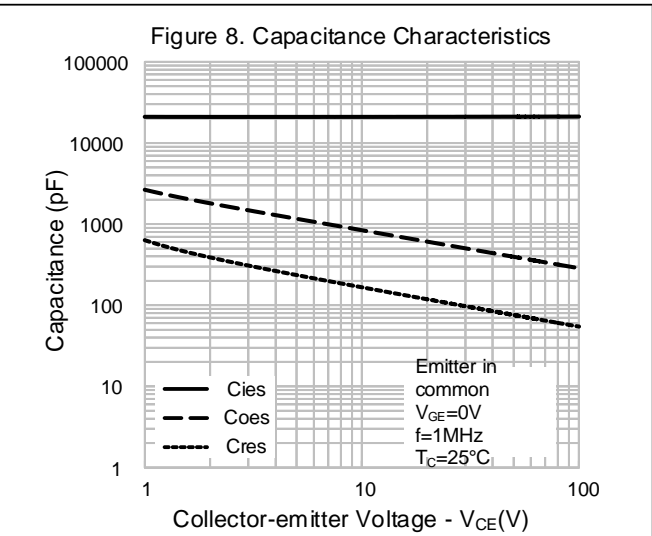
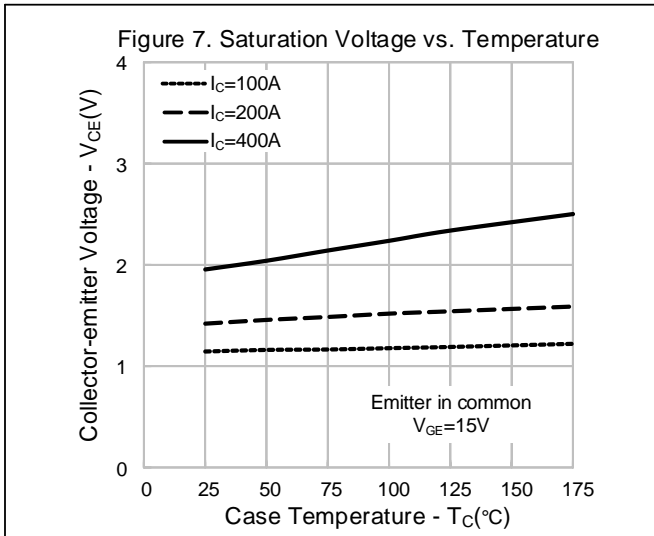
ELECTRICAL CHARACTERISTICS OF FRD (T_C=175°C)

Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Diode Reverse Recovery Time	T _{rr}	I _{ES} =200A, dI _{ES} /dt=200A/μs, T _C =175°C	--	500	--	ns
Diode Reverse Recovery Charge	Q _{rr}		--	18	--	μC
Diode Reverse Recovery Current	I _{rrm}		--	19	--	A

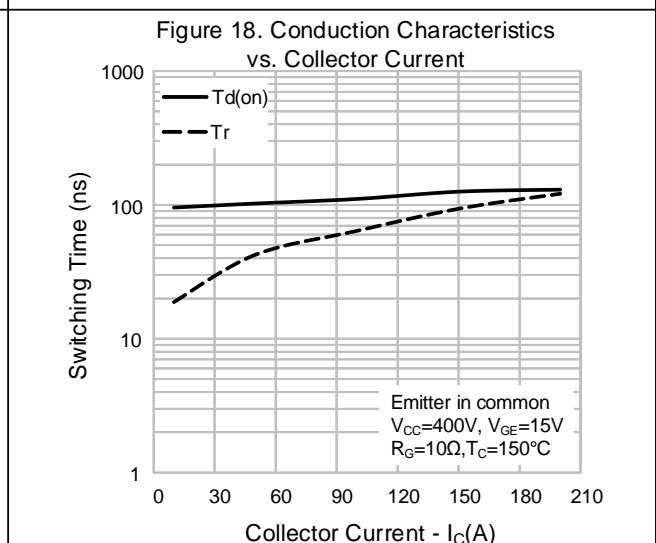
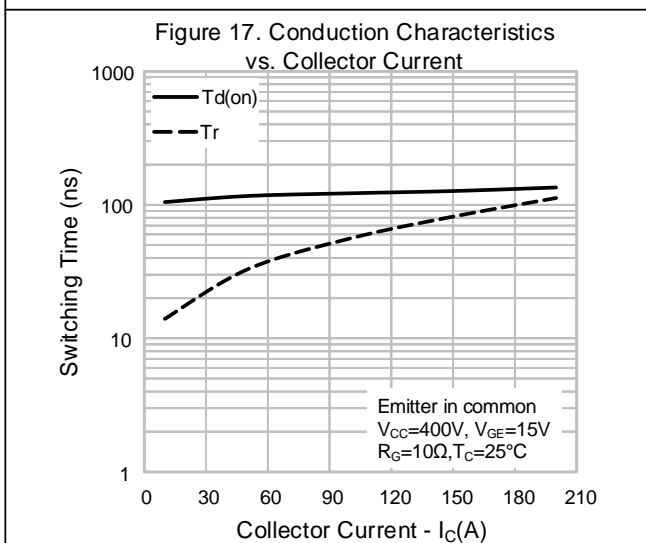
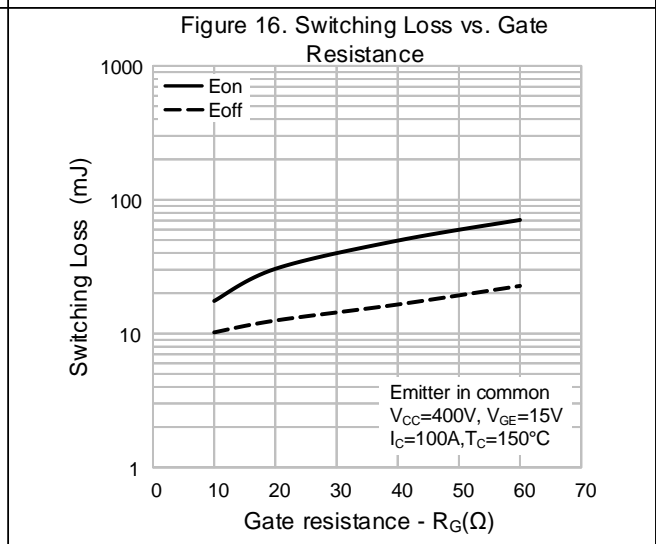
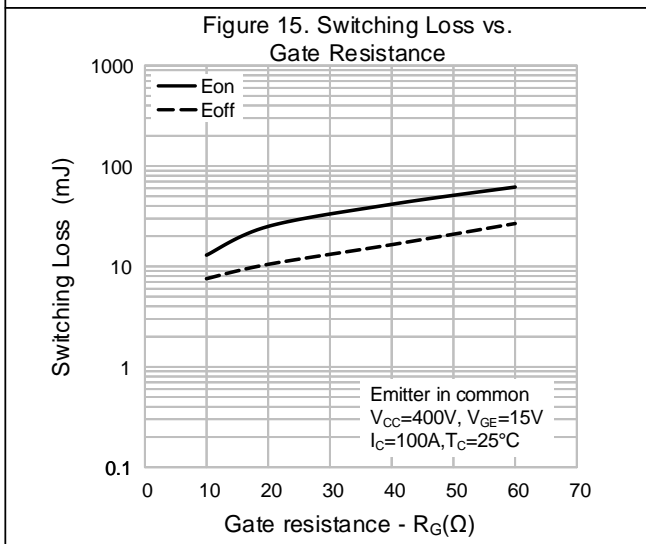
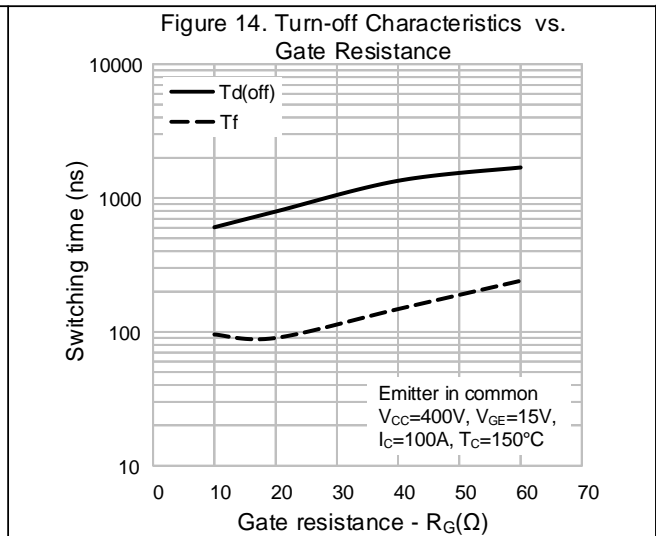
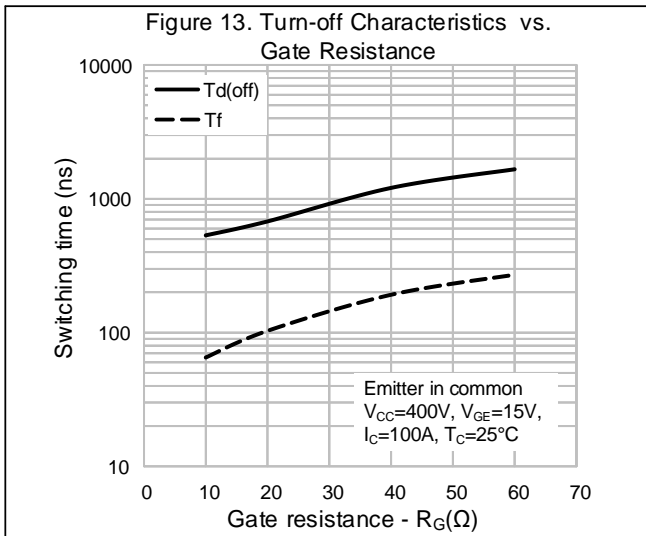
TYPICAL CHARACTERISTICS



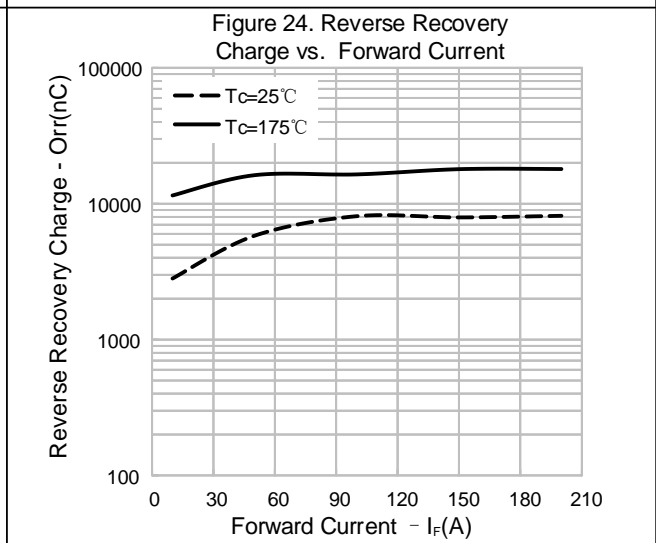
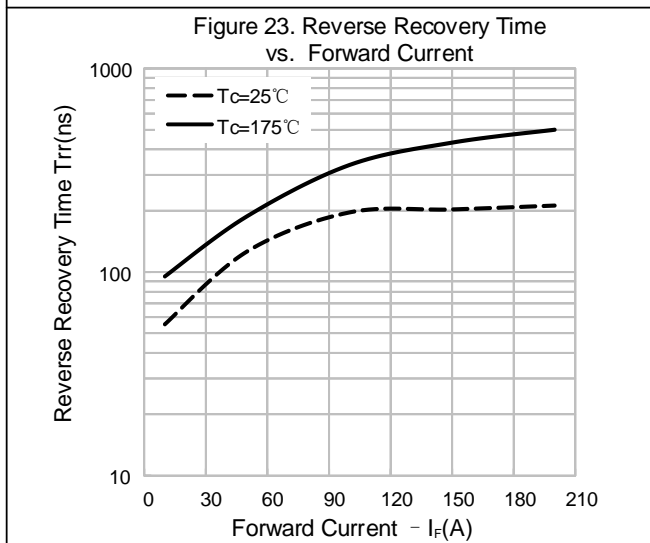
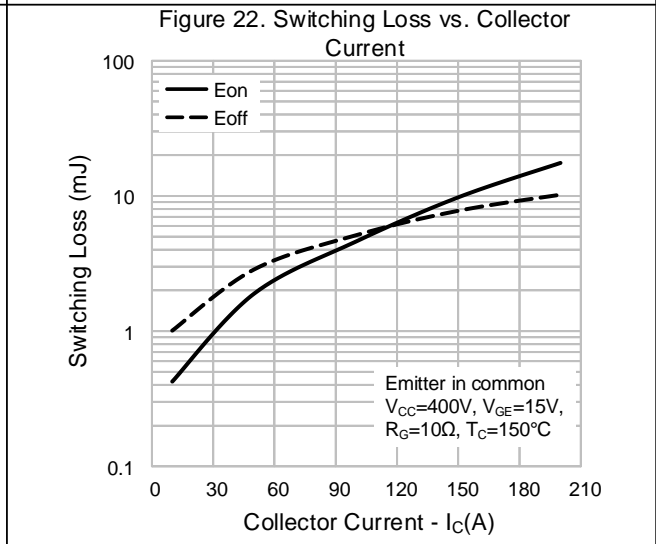
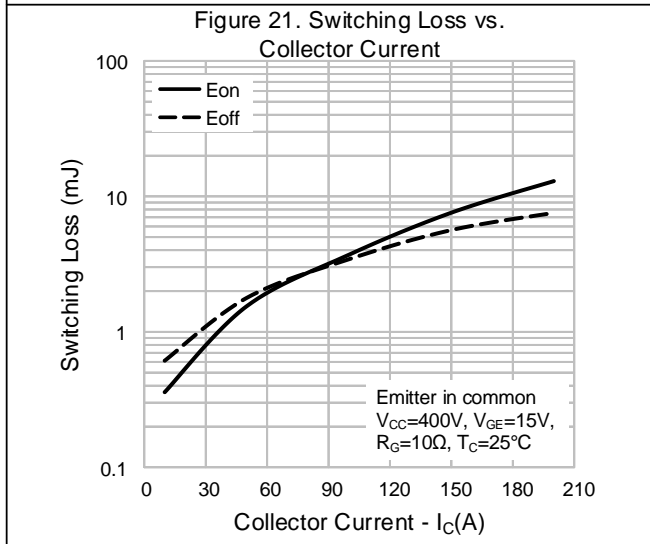
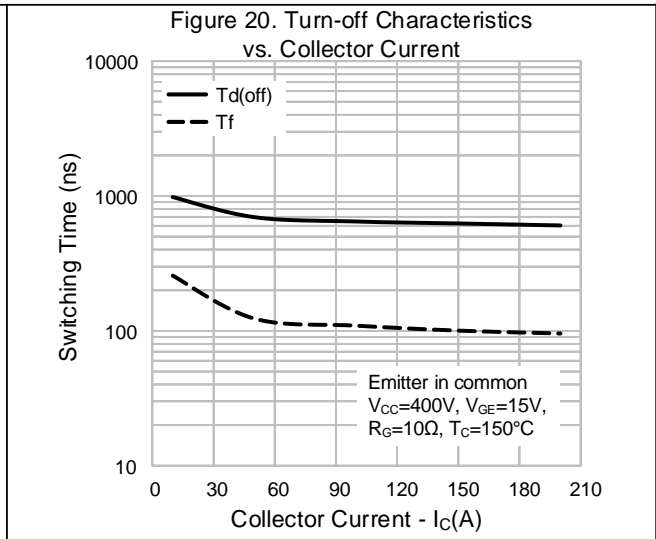
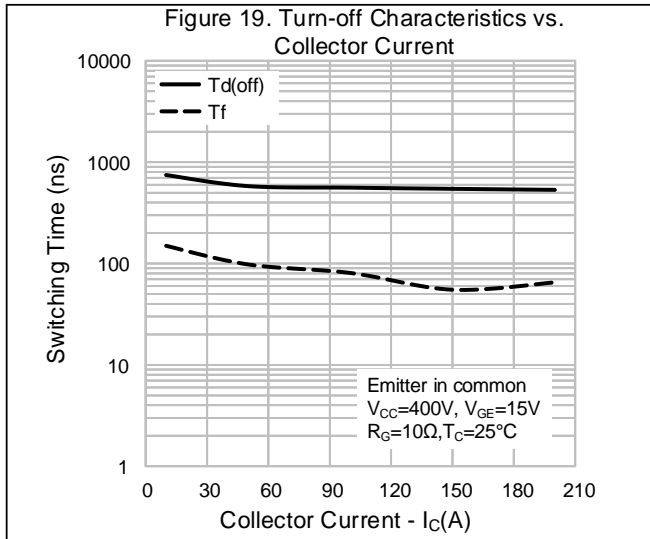
TYPICAL CHARACTERISTICS (CONTINUED)



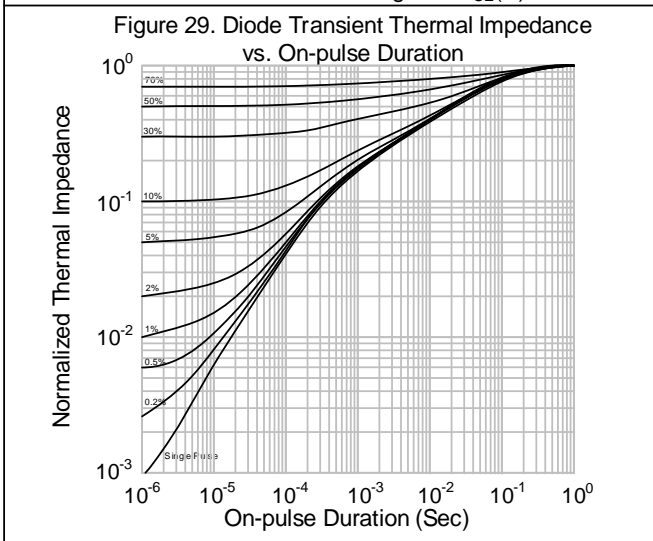
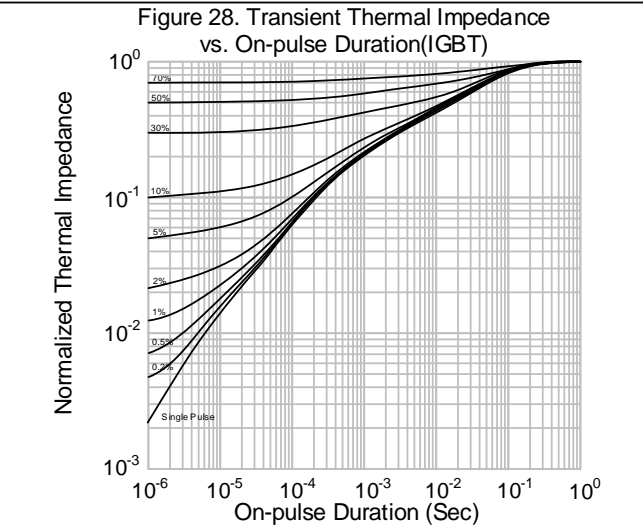
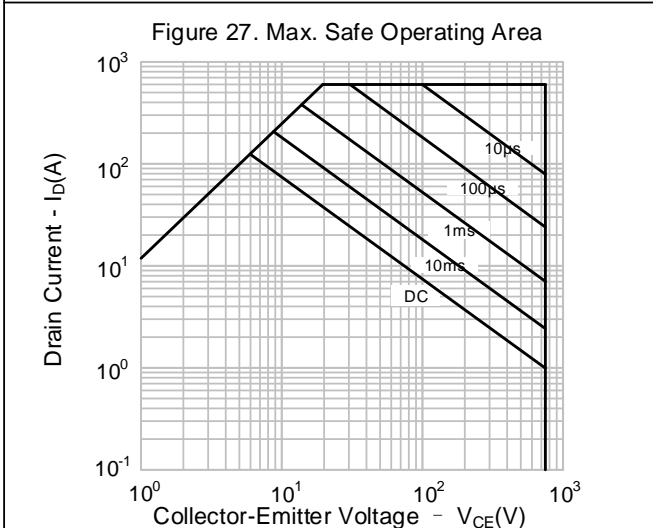
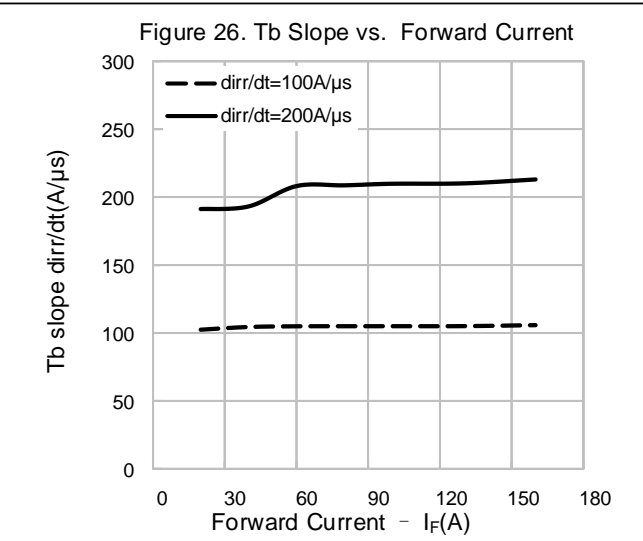
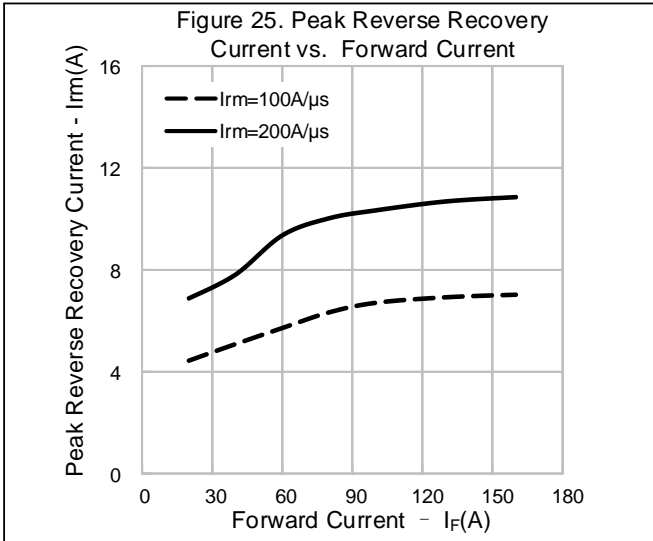
TYPICAL CHARACTERISTICS (CONTINUED)



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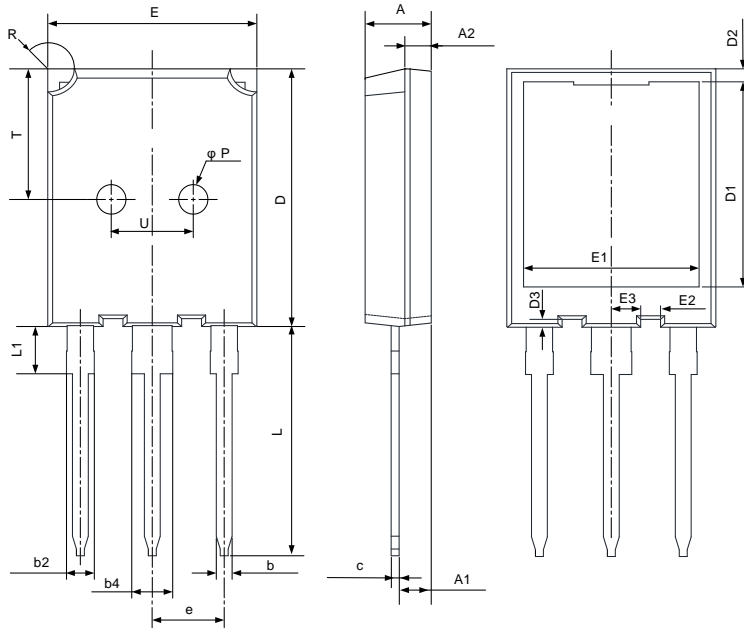
TYPICAL CHARACTERISTICS (CONTINUED)



PACKAGE OUTLINE

TO-247P-3L

UNIT: mm



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16	—	1.26
b2	—	—	2.25
b4	—	—	3.25
c	0.59	—	0.66
D	20.90	21.00	21.10
D1	16.25	16.55	16.85
D2	1.05	1.17	1.35
D3	0.58	—	0.78
e	5.436 BSC		
E	15.70	15.80	15.90
E1	13.10	13.30	13.50
E2	1.40	1.50	1.60
E3	2.12	2.22	2.32
L	19.80	19.95	20.10
L1	—	—	4.30
T	9.80	—	10.20
P	2.40	2.50	2.60
U	6.00	—	6.40
R	1.90	—	2.10



MOS DEVICES OPERATE NOTES:

Electrostatic charges may exist in many things. Please take following preventive measures to prevent effectively the MOS electric circuit as a result of the damage which is caused by discharge:

- The operator must put on wrist strap which should be earthed to against electrostatic.
- Equipment cases should be earthed.
- All tools used during assembly, including soldering tools and solder baths, must be earthed.
- MOS devices should be packed in antistatic/conductive containers for transportation.

Important notice:

1. Silan reserves the right to make changes of this instruction without notice.
2. Customers should obtain the latest relevant information when purchasing and should verify whether such information is latest and complete. Please read this instruction and application manual and related materials carefully before using products, including the circuit operation precautions, etc.
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Rev.: 1.2

Revision History:

1. Update electrical characteristics
 2. Update typical characteristics
 3. Update important notice
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Rev.: 1.1

Revision History:

1. Modify features
 2. Update package outline
-

Rev.: 1.0

Revision History:

1. First release
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